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```
(weight mask*) <and>
(accumulat* <or> mean <or>
average <or> square)
```

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1 **Computing the scatter component of mammographic images**
Highnam, R.P.; Brady, J.M.; Shepstone, B.J.;
Medical Imaging, IEEE Transactions on ,Volume: 13 , Issue: 2 , June 1994
Pages:301 - 313

[Abstract]   [PDF Full-Text (956KB)]   IEEE JNL

2 **Human face detection using geometric triangle relationship**
Chiunhsiun Lin; Kuo-Chin Fan;
Pattern Recognition, 2000. Proceedings. 15th International Conference on
,Volume: 2 , 3-7 Sept 2000
Pages:941 - 944 vol.2

[Abstract]   [PDF Full-Text (500KB)]   IEEE CNF

3 **Video-based face recognition using probabilistic appearance manifo**
Kuang-Chih Lee; Ho, J.; Ming-Hsuan Yang; Kriegman, D.;
Computer Vision and Pattern Recognition, 2003. Proceedings. 2003 IEEE Com
Society Conference on ,Volume: 1 , 18-20 June 2003
Pages:I-313 - I-320 vol.1

[Abstract]   [PDF Full-Text (455KB)]   IEEE CNF

4 **Creation of weighted volume grating by holographic method**
Zaitsev, A.K.; Shiuan Huei Lin; Hsu, K.Y.;
Lasers and Electro-Optics, 2001. CLEO/Pacific Rim 2001. The 4th Pacific Rim
Conference on ,Volume: 2 , 15-19 July 2001
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5 **A fast algorithm for image restoration using a recurrent neural netv
with bound-constrained quadratic optimization**
Gendy, S.; Kothapalli, G.; Bouzerdoum, A.;
Intelligent Information Systems Conference, The Seventh Australian and New
Zealand 2001 , 18-21 Nov. 2001

Pages:111 - 115

[Abstract]   [PDF Full-Text (382KB)]   **IEEE CNF**

6 **Weights determination for minimum cost flow InSAR phase unwrap**
Refice, A.; Satalino, G.; Stramaglia, S.; Chiaradia, M.T.; Veneziani, N.;
Geoscience and Remote Sensing Symposium, 1999. IGARSS '99 Proceedings.
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[Abstract]   [PDF Full-Text (436KB)]   **IEEE CNF**

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